

LIST OF REFERENCES CITED BY APPLICANT

Atty Docket No.: 4100-98
Serial No.: ~~a/a~~ 09/041,416
Applicant: Alfons SCHUSTER et al.

Filing Date: ~~concurrently~~ 3/12/98
Group Art: 2854

JC511 U.S. PTO

09/041416



03/12/98

U.S. PATENT DOCUMENTS

*Ex. Ints.		Document No.	Date	Name	Class	Subclass	Filing Date
	AA						
	AB						
	AC						
	AD						
	AE						

FOREIGN PATENT DOCUMENTS

*Ex. Ints.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
AF	AF	0 099 264	1/25/84	Europe	Doyle	—		Yes
AG	AG	0 580 394	1/26/94	Europe	Lewis	—		Yes
AH	AH	101266	2/22/84	Europe	Love	—		
	AI							
	AJ							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

AK	AK		"Technologie des Offsetdrucks", Riedl et al.; VEB Fachbuchverlag Leipzig; pg. 105-111; 1989.
	AO		
	AP		

EXAMINER: Stephen F. Fink DATE CONSIDERED: 8/25/98

* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.